

TEST REPORT

Applicant: JIAHANG TECHNOLOGY (HONG KONG) CO., LIMITED
Address: 19H MAXGRAND PLAZA 3 TAI YAU STREET SAN PO KONG KL
Equipment Type: Tablet
Model Name: K8
Brand Name: N/A
Test Standard: 47 CFR Part 15 Subpart B
ANSI C63.4-2014
Sample Arrival Date: Jul. 21, 2026
Test Date: Aug. 05, 2026 - Aug. 06, 2026
Date of Issue: Aug. 07, 2026

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

Tested by: Li JunFeng

Checked by: Zong Liyao

Approved by: Liao Jianming
(Technical Director)

Li JunFeng

Zong Liyao

Jm Liao

Revision History

Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>Aug. 07, 2026</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	601, Building 2, Intelligent Connected Vehicle Industrial Park, No.55, Xiangshan Road, Luotian Community, Yanluo Sub-district, Bao'an District, Shenzhen
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	☐ Building 2, Intelligent Connected Vehicle Industrial Park, No.55, Xiangshan Road, Luotian Community, Yanluo Sub-district, Bao'an District, Shenzhen, Guangdong
	☒ 1/F., Building B, Ganghongji High-Tech Intelligent Industrial Park, No.1008, Songbai Road, Yangguang Community, Xili Subdistrict, Nanshan District, Shenzhen, Guangdong
Accreditation Certificate	The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196. The certification body is American Association for Laboratory Accreditation (A2LA).

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	JIAHANG TECHNOLOGY (HONG KONG) CO., LIMITED
Address	19H MAXGRAND PLAZA 3 TAI YAU STREET SAN PO KONG KL

2.2 Manufacturer Information

Manufacturer	LUZHENG TECHNOLOGY HONGKONG LIMITED
Address	ROOM A08, 2/F LEE KA INDUSTRIAL BUILDING 8 NG FONG STREET SAN PO KONG HK

2.3 General Description for Equipment under Test (EUT)

EUT Name	Tablet
Model Name Under Test	K8
Series Model Name	N/A
Description of Model name differentiation	N/A
Hardware Version	SQ8T-7731E-W-V2.0
Software Version	N/A
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.4 Ancillary Equipment

Ancillary Equipment 1	Li-Polymer Battery	
	Brand Name	N/A
	Model No.	H356888PLHTT
	Serial No.	N/A
	Capacitance	3000mAh
	Rated Voltage	3.8 V
	Limited Voltage	/
	Manufacturer	Shenzhen HuaTianTong Technology Co., Ltd.
Ancillary Equipment 2	USB Cable	
	Model No.	N/A
	Length (Approx.)	1.0 m

2.5 Technical Information

Network and Wireless connectivity	Bluetooth (BR+EDR+BLE) WIFI 802.11b, 802.11g, 802.11n(HT20)
Classification of equipment	Class B

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B	Unintentional Radiators
2	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Remark
1	Radiated Emission	15.109	Pass	--
2	Conducted Emission, AC Ports	15.107	Pass	--

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

Measurement	Value
Conducted emissions (9 kHz-150 KHz)-AMN	3.36 dB
Conducted emissions (150 kHz-30 MHz)-AMN	2.92 dB
Radiated emissions (30 MHz-1 GHz)	4.24 dB
Radiated emissions (1 GHz-6 GHz)	5.10 dB
Radiated emissions (6 GHz-18 GHz)	5.30 dB

4 GENERAL TEST CONFIGURATIONS

4.1 Test Enclosure List

Description	Manufacturer	Model	Serial No.	Length	Description	Use
Laptop	HONOR	N/A	N/A	N/A	N/A	☒
Data connector	HBR	type-c to USB	N/A	N/A	N/A	☒
USB disk	Sandisk	CZ73-32G	N/A	N/A	N/A	☒
TF Card	N/A	N/A	N/A	N/A	N/A	☒
TYPE-C Earphone	Xiaomi	M1213E1	N/A	N/A	N/A	☒
3.5mm Earphone	N/A	N/A	N/A	N/A	N/A	☒
Adapter	N/A	N/A	N/A	N/A	N/A	☒

4.2 Test Configurations

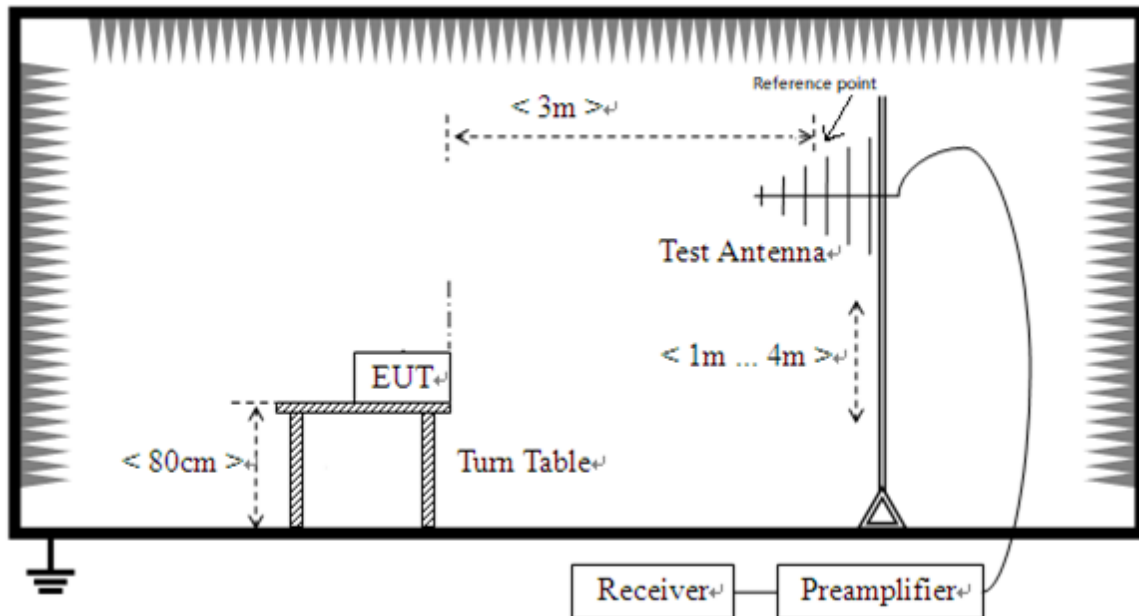
All test modes of EUT are listed in the table below.

Test Mode Configuration	Description
Mode 1	<u>The Front Camera Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + 3.5mm Earphone
Mode 2	<u>The Rear Camera Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + 3.5mm Earphone
Mode 3	<u>The H-pattern Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + 3.5mm Earphone
Mode 4	<u>The Charging Test Mode</u> EUT + Adapter + USB Cable + Battery + TF Card + 3.5mm Earphone
Mode 5	<u>The USB Test Mode</u> EUT + USB Cable + Battery + Laptop + TF Card + 3.5mm Earphone
Mode 6	<u>The Type-C Earphone Test Mode</u> EUT + Type-C Earphone + TF Card
Mode 7	<u>The OTG Test Mode</u> EUT + Battery + Data connector + USB Disk + TF Card + 3.5mm Earphone

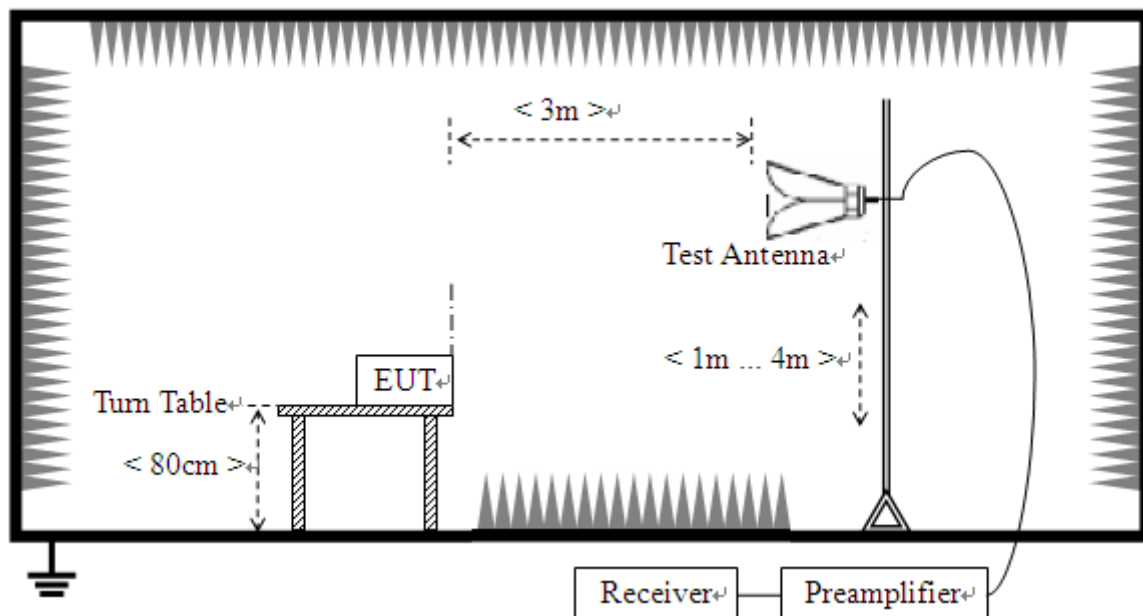
Test Case	Test Mode Configuration	Worst Mode
Radiated Emission	Mode 1~Mode 7	1
Conducted Emission, AC Ports	Mode 1~Mode 5	3
Note: All operation modes were tested, but only test data of the worst mode was presented in this report.		

4.3 Test Setups

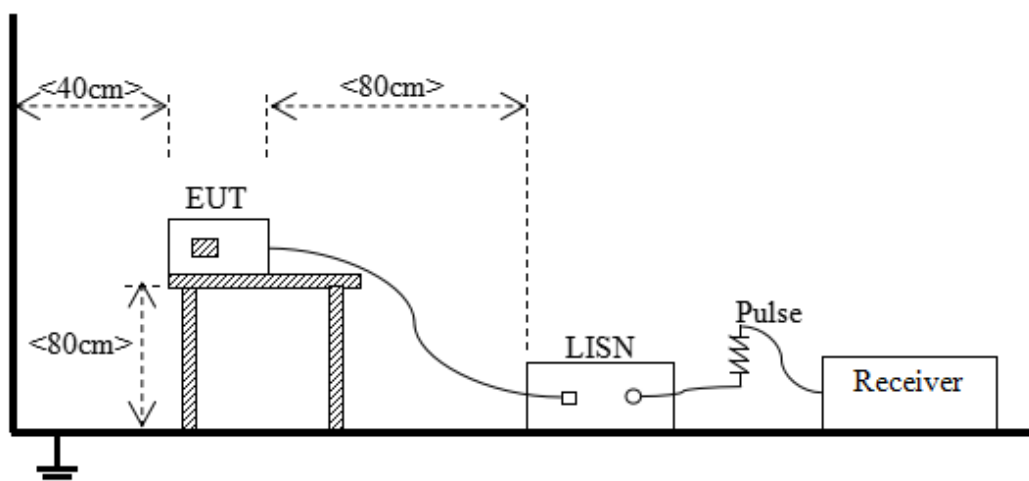
Test Setup 1



Radiated Emission (30 MHz-1 GHz)



Radiated Emission (above 1 GHz)

Test Setup 2

Conducted Emissions, AC Ports

5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency range (MHz)	Class B (at 3 m)		Class A (at 3 m)
	Field Strength ($\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)
30 - 88	100	40	49.5
88 - 216	150	43.5	54
216 - 960	200	46	56.9
Above 960	500	54	60

NOTE:

- 1) Field Strength (dB $\mu\text{V/m}$) = $20 \cdot \log [\text{Field Strength } (\mu\text{V/m})]$.
- 2) In the emission tables above, the tighter limit applies at the band edges.
- 3) For 30 MHz to 1000 MHz, the CISPR quasi-peak is employed.

For above 1000 MHz, according to the requirements of FCC 15.35, unless otherwise specified, the limit on peak radio frequency emissions is 20 dB above the maximum permitted average emission limit applicable to the equipment under test.

Frequency range (GHz)	Class B (at 3 m)			Class A (at 3 m)	
	Field Strength ($\mu\text{V/m}$)	Field Strength Average (dB $\mu\text{V/m}$)	Field Strength Peak (dB $\mu\text{V/m}$)	Field Strength Average (dB $\mu\text{V/m}$)	Field Strength Peak (dB $\mu\text{V/m}$)
1 - F_M	500	54	74	60	80

Note 1: The highest measurement frequency, F_M , in GHz, shall be determined as next Table.

Note 2: Average Class A limit at 3m L_{3m} is determined by the following conversion formula:
 $L_{3m} = L_{10m} + 20 \cdot \log(d_{10m}/d_{3m})$
Where:
 L_{3m} is Average Class A limit at 3m;
 L_{10m} is Average Class A limit at 10m;
 d_{10m} is Measurement distance in 10m;
 d_{3m} is Measurement distance in 3m.
For this case: $L_{3m} = 49.5 + 20 \cdot \log(10/3) = 60$ (dB $\mu\text{V/m}$).

Highest internal frequency (F_X)	Highest measurement frequency (F_M)
$F_X \leq 108 \text{ MHz}$	1 GHz
$108 \text{ MHz} \leq F_X \leq 500 \text{ MHz}$	2 GHz
$500 \text{ MHz} \leq F_X \leq 1 \text{ GHz}$	5 GHz
$F_X \geq 1 \text{ GHz}$	$5 * F_X$ or 40 GHz, whichever is lower.
Note: F_X is Highest frequency generated or used in the device or on which the device operates or tunes.	

5.1.1.2 Test Setup

Refer to 4.3 section (test setup 1) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

All Radiated Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

The measurement frequency range is from 30 MHz to the 5th harmonic of the maximum frequency of the EUT internal source. The Turn Table is actuated to turn from 0° to 360° , and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for $f \geq 1 \text{ GHz}$, 100 kHz for $f < 1 \text{ GHz}$

VBW $\geq$ RBW

Sweep = auto

Detector function = peak for $f < 1 \text{ GHz}$, peak & RMS Average for $f \geq 1 \text{ GHz}$

Trace = max hold

5.1.1.4 Test Result and Test Equipment List

Please refer to ANNEX A.1.

NOTE:

1. Results (dB μ V/m) = Reading (dB μ V) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain (dB)

3. Margin = Limit - Results

5.1.2 Conducted Emission, AC Ports

5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dB μ V)	Average (dB μ V)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.

5.1.2.2 Test Setup

Refer to 4.3 section test (test setup 2) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides 50 Ω /50 μ H of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

Use the following spectrum analyzer settings:

RBW = 9 kHz

VBW $\geq$ RBW

Sweep = 10ms

Detector function = peak & Average

Trace = max hold

5.1.2.4 Test Result and Test Equipment List

Please refer to ANNEX A.2.

NOTE:

1. Results (dBμV) = Reading (dBμV) + Factor (dB)

The reading level is calculated by software which is not shown in the sheet

2. Factor = Insertion loss + Cable loss

3. Margin = Limit - Results

ANNEX A TEST RESULTS

A.1 Radiated Emission

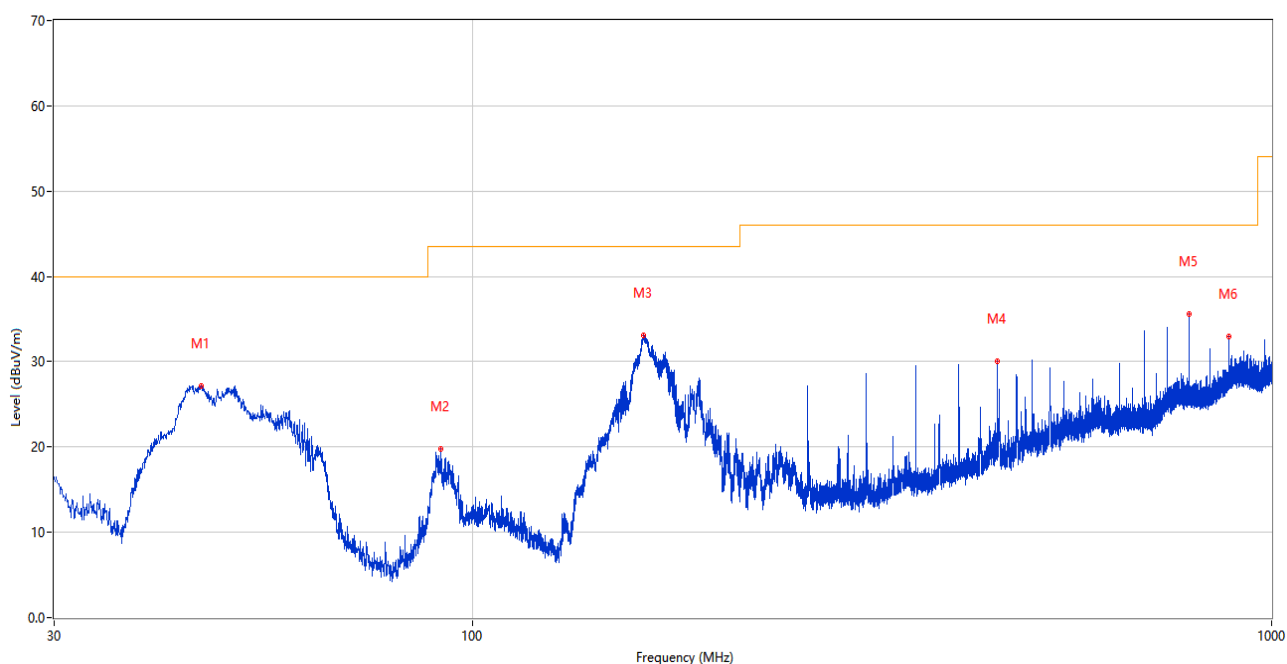
Note 1: The symbol of "--" in the table which means not application.

Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Sample No.	S01	Temperature	23.2℃
Humidity	61%RH	Pressure	99.7kPa
Test Engineer	Wu Yunan	Test Date	2026.08.06

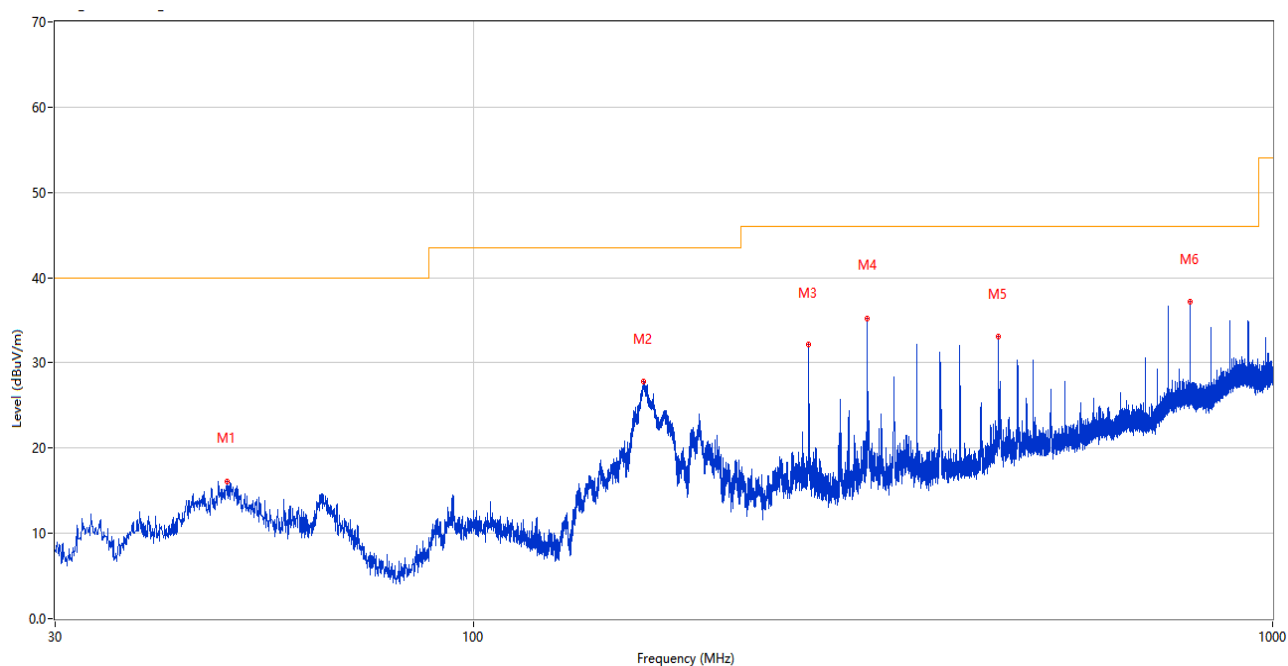
Test Mode 1

1) Test Antenna Vertical, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	45.859	27.10	-25.46	40.0	12.90	Peak	195.00	100	Vertical	Pass
2	91.401	19.78	-27.77	43.5	23.72	Peak	0.00	100	Vertical	Pass
3	163.860	33.05	-28.62	43.5	10.45	Peak	346.00	100	Vertical	Pass
4	454.181	29.99	-19.59	46.0	16.01	Peak	175.00	200	Vertical	Pass
5	788.831	35.61	-11.21	46.0	10.39	Peak	114.00	100	Vertical	Pass
6	884.473	32.96	-9.39	46.0	13.04	Peak	299.00	100	Vertical	Pass

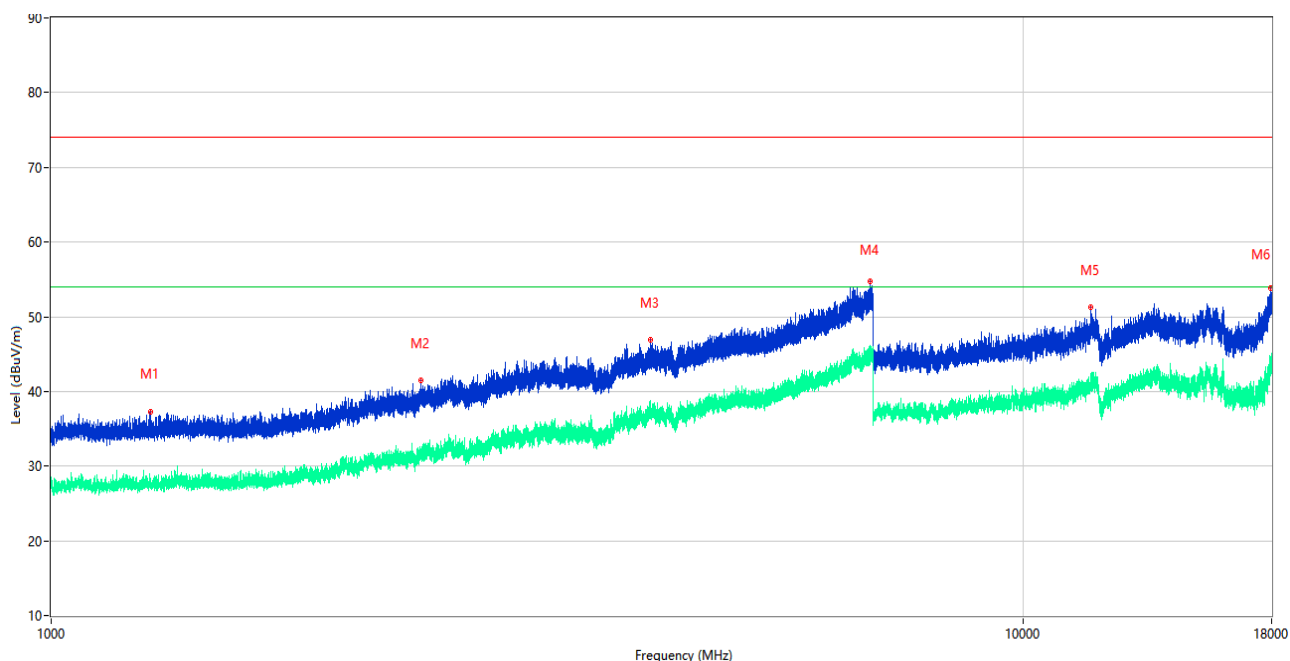
2) Test Antenna Horizontal, 30 MHz – 1 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	49.157	16.14	-25.24	40.0	23.86	Peak	268.00	100	Horizontal	Pass
2	163.278	27.79	-28.66	43.5	15.71	Peak	60.00	200	Horizontal	Pass
3	262.945	32.12	-24.76	46.0	13.88	Peak	46.00	100	Horizontal	Pass
4	310.766	35.22	-23.30	46.0	10.78	Peak	158.00	100	Horizontal	Pass
5	454.181	33.14	-19.59	46.0	12.86	Peak	199.00	100	Horizontal	Pass
6	788.879	37.21	-11.22	46.0	8.79	Peak	332.00	100	Horizontal	Pass

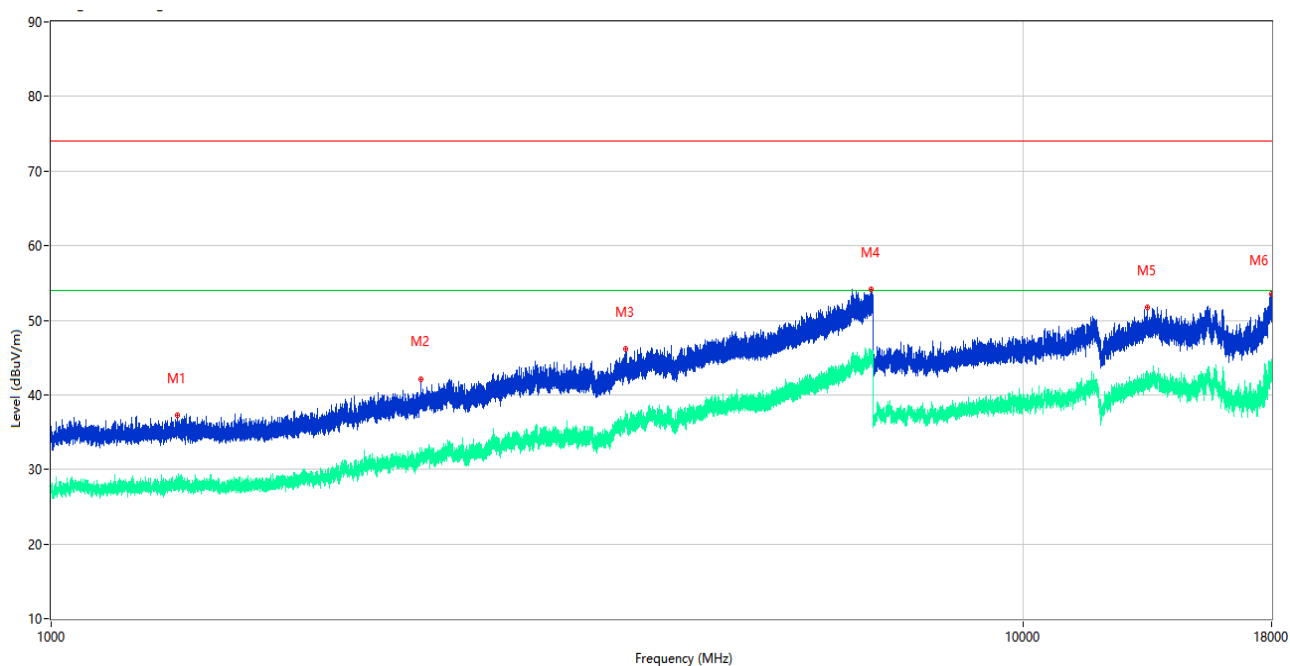
Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Below 1 GHz						
EMI Receiver	Keysight	N9038A	MY55330121	2025.12.26	2026.12.25	☒
Test Antenna-Bi-Log	SCHWARZB ECK	VULB 9163	01414	2023.11.03	2026.11.02	☒
Amplifier (30MHz-1GHz)	COM-MW	ZT30-1000M	19061432	2026.04.15	2027.04.14	☒
Anechoic Chamber	EMC Electronic Co., Ltd	C8-966	107	2024.05.12	2027.05.11	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

3) Test Antenna Vertical, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1263.900	37.34	-17.89	74.0	36.66	Peak	317.00	100	Vertical	Pass
1**	1263.900	27.60	-17.89	54.0	26.40	AV	317.00	100	Vertical	Pass
2	2398.410	41.49	-13.62	74.0	32.51	Peak	136.00	100	Vertical	Pass
2**	2398.410	31.47	-13.62	54.0	22.53	AV	136.00	100	Vertical	Pass
3	4135.160	46.91	-5.53	74.0	27.09	Peak	44.00	100	Vertical	Pass
3**	4135.160	37.60	-5.53	54.0	16.40	AV	44.00	100	Vertical	Pass
4	6951.380	54.70	0.67	74.0	19.30	Peak	141.00	100	Vertical	Pass
4**	6951.380	45.19	0.67	54.0	8.81	AV	141.00	100	Vertical	Pass
5	11737.150	51.25	5.51	74.0	22.75	Peak	63.00	100	Vertical	Pass
5**	11737.150	41.95	5.51	54.0	12.05	AV	63.00	100	Vertical	Pass
6	17978.550	53.83	9.95	74.0	20.17	Peak	278.00	100	Vertical	Pass
6**	17978.550	43.92	9.95	54.0	10.08	AV	278.00	100	Vertical	Pass

4) Test Antenna Horizontal, 1 GHz – 18 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (Degree)	Height (cm)	Antenna	Verdict
1	1348.010	37.28	-17.73	74.0	36.72	Peak	198.00	100	Horizontal	Pass
1**	1348.010	28.42	-17.73	54.0	25.58	AV	198.00	100	Horizontal	Pass
2	2398.020	42.14	-13.63	74.0	31.86	Peak	194.00	100	Horizontal	Pass
2**	2398.020	31.27	-13.63	54.0	22.73	AV	194.00	100	Horizontal	Pass
3	3901.580	46.19	-5.72	74.0	27.81	Peak	333.00	100	Horizontal	Pass
3**	3901.580	36.73	-5.72	54.0	17.27	AV	333.00	100	Horizontal	Pass
4	6970.080	54.09	0.59	74.0	19.91	Peak	201.00	100	Horizontal	Pass
4**	6970.080	45.01	0.59	54.0	8.99	AV	201.00	100	Horizontal	Pass
5	13421.799	51.73	5.53	74.0	22.27	Peak	0.00	100	Horizontal	Pass
5**	13421.799	42.25	5.53	54.0	11.75	AV	0.00	100	Horizontal	Pass
6	17980.750	53.55	9.92	74.0	20.45	Peak	158.00	100	Horizontal	Pass
6**	17980.750	43.25	9.92	54.0	10.75	AV	158.00	100	Horizontal	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
Frequency Above 1 GHz						
EMI Receiver	Keysight	N9038A	MY55330121	2025.12.26	2026.12.25	☒
Test Antenna-Horn	SCHWARZB ECK	BBHA 9120D	02459	2023.10.26	2026.10.25	☒
Amplifier (1-12GHz)	COM-MW	LSCX-LMA1-12G-01	19061431	2026.04.15	2027.04.14	☒
Amplifier (7-18GHz)	COM-MW	XKu_LNA7-18G-01	07210208	2026.04.15	2027.04.14	☒
Anechoic Chamber	EMC Electronic Co., Ltd	C8-966	107	2024.05.12	2027.05.11	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

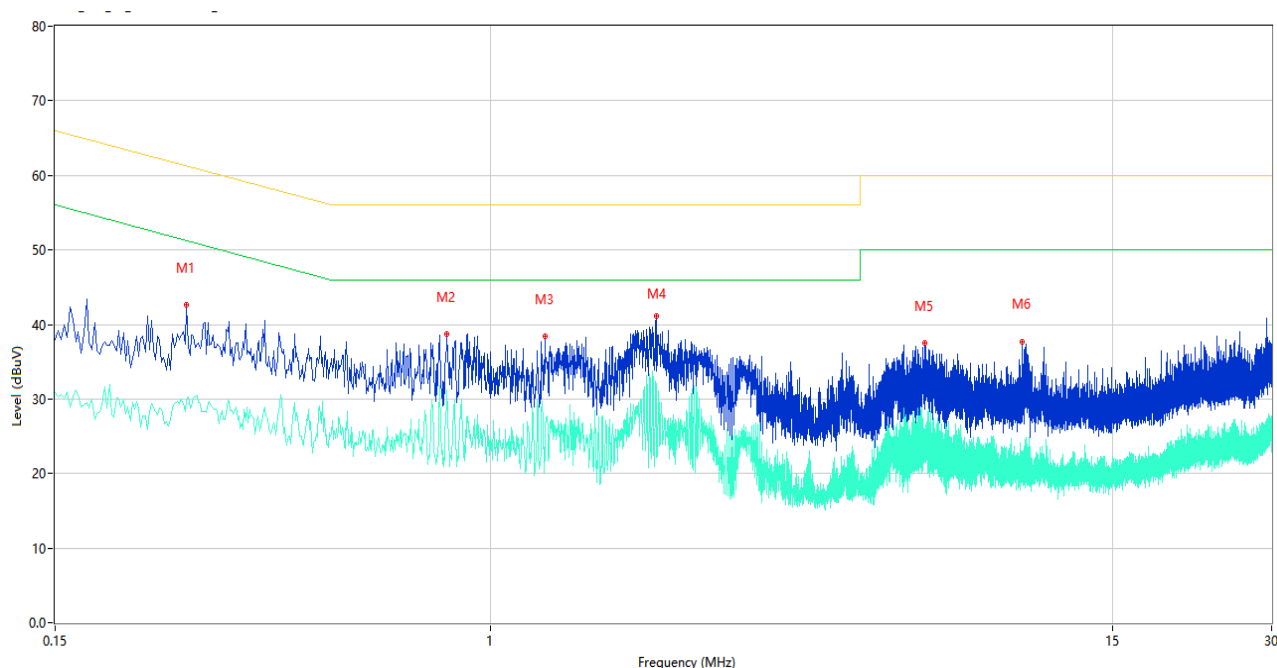
A.2 Conducted Emission, AC Ports

Note: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (120 VAC, 60 Hz) shown here.

Sample No.	S01	Temperature	21.9℃
Humidity	59%RH	Pressure	99.7kPa
Test Engineer	Tian Hengzhao	Test Date	2026.08.06

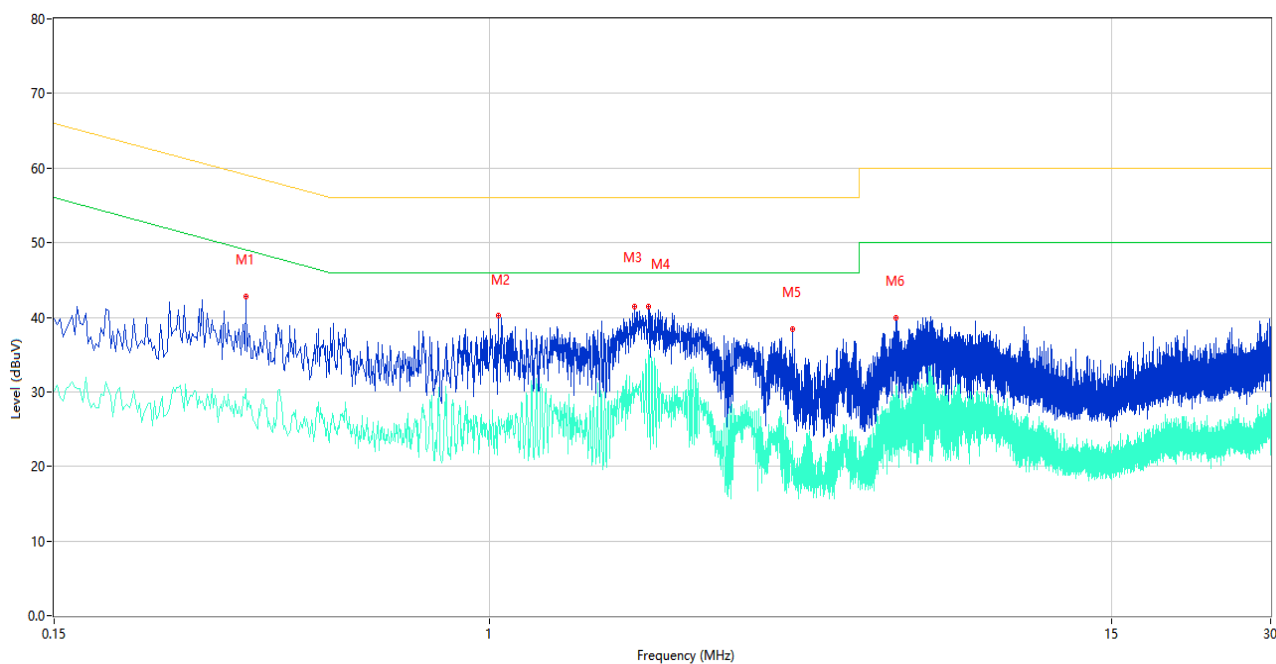
Test Mode 3

1) AC Ports - L Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.266	42.67	10.23	61.24	18.57	Peak	L	Pass
1**	0.266	29.87	10.23	51.24	21.37	AV	L	Pass
2	0.826	38.70	10.29	56.00	17.30	Peak	L	Pass
2**	0.826	31.22	10.29	46.00	14.78	AV	L	Pass
3	1.266	38.44	10.34	56.00	17.56	Peak	L	Pass
3**	1.266	23.02	10.34	46.00	22.98	AV	L	Pass
4	2.054	41.15	10.46	56.00	14.85	Peak	L	Pass
4**	2.054	32.15	10.46	46.00	13.85	AV	L	Pass
5	6.624	37.48	11.97	60.00	22.52	Peak	L	Pass
5**	6.624	24.19	11.97	50.00	25.81	AV	L	Pass
6	10.138	37.71	12.52	60.00	22.29	Peak	L	Pass
6**	10.138	20.11	12.52	50.00	29.89	AV	L	Pass

2) AC Ports - N Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.346	42.82	10.22	59.06	16.24	Peak	N	Pass
1**	0.346	30.40	10.22	49.06	18.66	AV	N	Pass
2	1.038	40.17	10.29	56.00	15.83	Peak	N	Pass
2**	1.038	26.40	10.29	46.00	19.60	AV	N	Pass
3	1.882	41.48	10.41	56.00	14.52	Peak	N	Pass
3**	1.882	30.04	10.41	46.00	15.96	AV	N	Pass
4	2.000	41.49	10.43	56.00	14.51	Peak	N	Pass
4**	2.000	35.49	10.43	46.00	10.51	AV	N	Pass
5	3.742	38.45	10.75	56.00	17.55	Peak	N	Pass
5**	3.742	22.78	10.75	46.00	23.22	AV	N	Pass
6	5.854	39.96	11.56	60.00	20.04	Peak	N	Pass
6**	5.854	28.80	11.56	50.00	21.20	AV	N	Pass

Equipment Information						
Equipment Name	Supplier	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9038B	MY61380132	2025.12.26	2026.12.25	☒
LISN	SCHWARZBECK	NSLK 8127	01009	2026.06.22	2027.06.21	☒
Shielded Room	YiHeng Electronic Co., Ltd	/	235	2024.11.05	2027.11.04	☒
Description	Supplier	Name	Version	/		Use
Test Software	BALUN	BL410-E	V22.4 en	/		☒

ANNEX B TEST SETUP PHOTOS

Please refer the document “Ti-CC26070305-AE-1.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “Ti-CC26070305-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “Ti-CC26070305-AI.PDF”.

Statement

1. The laboratory guarantees the scientificity, accuracy and impartiality of the test, and is responsible for all the information in the report, except the information provided by the customer. The customer is responsible for the impact of the information provided on the validity of the results.
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--END OF REPORT--